

# **Electrical Datasheet\***

# GB50SLT12-CAL

# Silicon Carbide Power Schottky Diode Chip

 $V_{RRM}$  = 1200 V  $V_{F}$  = 1.6 V  $I_{F (Tc = 25^{\circ}C)}$  = 100 A  $Q_{C}$  = 158 nC

#### **Features**

- 1200 V Schottky rectifier
- 175 °C maximum operating temperature
- Positive temperature coefficient of V<sub>F</sub>
- Fast switching speeds
- Superior figure of merit Q<sub>C</sub>/I<sub>F</sub>



# **Advantages**

- Improved circuit efficiency (Lower overall cost)
- Significantly reduced switching losses compare to Si PiN diodes
- Ease of paralleling devices without thermal runaway
- · Smaller heat sink requirements
- Low reverse recovery current
- · Low device capacitance

#### **Applications**

- Down Hole Oil Drilling, Geothermal Instrumentation
- · High Voltage Multipliers
- Military Power Supplies

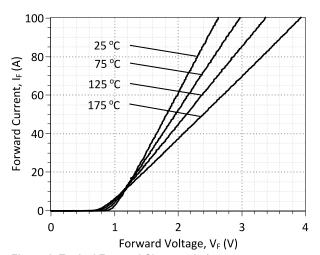
#### Maximum Ratings at $T_j = 175$ °C, unless otherwise specified

Parameter	Symbol	Conditions	Values	Unit
Repetitive peak reverse voltage	$V_{RRM}$		1200	V
Continuous forward current	$I_{F}$	T <sub>C</sub> = 25 °C	100	Α
Continuous forward current	l <sub>F</sub>	T <sub>C</sub> ≤ 135 °C	50	Α
RMS forward current	$I_{F(RMS)}$	T <sub>C</sub> ≤ 135 °C	87	Α
Surge non-repetitive forward current, Half Sine	1	$T_{\rm C}$ = 25 °C, $t_{\rm P}$ = 10 ms	350	۸
Wave	I <sub>F,SM</sub>	$T_{\rm C}$ = 135 °C, $t_{\rm P}$ = 10 ms	313	Α
Non-repetitive peak forward current	$I_{F,max}$	$T_C$ = 25 °C, $t_P$ = 10 $\mu$ s	1625	Α
l <sup>2</sup> t value	∫i² dt	$T_C$ = 25 °C, $t_P$ = 10 ms	tbd	$A^2S$
Power dissipation	$P_{tot}$	T <sub>C</sub> = 25 °C	620	W
Operating and storage temperature	$T_j$ , $T_stg$		-55 to 175	°C

# Electrical Characteristics at $T_j$ = 175 °C, unless otherwise specified

Parameter	Symbol	Conditions -		Values		Unit	
Parameter	Symbol			min.	typ.	max.	Oilit
Diode forward voltage	$V_{F}$	$I_F = 50 \text{ A}, T_j = 25 ^{\circ}\text{C}$ 1.35		1.35	1.6	1.8	V
	٧F	$I_F = 50 \text{ A}, T_j = 175 \text{ °C}$		2.05	2.6	3.0	
Reverse current	I <sub>R</sub>	V <sub>R</sub> = 1200 V, T <sub>j</sub> = 25 °C		200	1000	μΑ	
		$V_R = 1200 \text{ V}, T_j = 175 ^{\circ}\text{C}$		400	3000		
Total capacitive charge	$Q_{C}$	$I_F \le I_{F,MAX}$	V <sub>R</sub> = 400 V		158		nC
Switching time	ts	− dl <sub>F</sub> /dt = 200 A/μs T <sub>j</sub> = 175 °C	V <sub>R</sub> = 400 V		50		ns
	С	$V_R = 1 \text{ V, f} = 1 \text{ MHz, T}_j = 25 \text{ °C}$		2940			
Total capacitance		$V_R = 400 \text{ V}, f = 1 \text{ MHz}, T_j = 25 ^{\circ}\text{C}$		203		pF	
		V <sub>R</sub> = 1000 V, f = 1 MH	z, T <sub>j</sub> = 25 °C		142		

<sup>\*</sup>For chip size and metallization, please refer to the mechanical datasheet (must have a non-disclosure agreement with GeneSiC Semiconductor).



**Figure 1: Typical Forward Characteristics** 

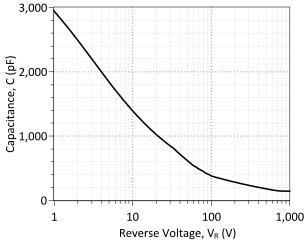


Figure 3: Typical Junction Capacitance vs Reverse Voltage Characteristics

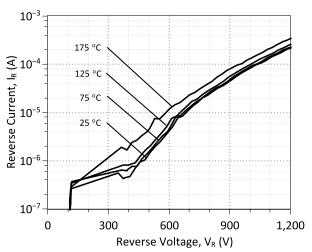


Figure 2: Typical Reverse Characteristics

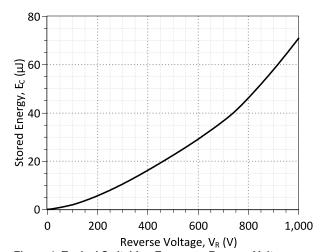


Figure 4: Typical Switching Energy vs Reverse Voltage Characteristics

	Revision History								
	Date	Revision	Comments	Supersedes					
Г	2014/09/12	2	Updated Electrical Characteristics						
	2013/11/12	1	Updated Electrical Characteristics						
	2013/09/18	0	Initial Release						

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### **SPICE Model Parameters**

Copy the following code into a SPICE software program for simulation of the GB50SLT12-CAL device.

```
MODEL OF GeneSiC Semiconductor Inc.
     $Revision: 1.0
     $Date: 04-SEP-2013
                               $
    GeneSiC Semiconductor Inc.
     43670 Trade Center Place Ste. 155
    Dulles, VA 20166
    http://www.genesicsemi.com/index.php/hit-sic/baredie
    COPYRIGHT (C) 2013 GeneSiC Semiconductor Inc.
     ALL RIGHTS RESERVED
* These models are provided "AS IS, WHERE IS, AND WITH NO WARRANTY
* OF ANY KIND EITHER EXPRESSED OR IMPLIED, INCLUDING BUT NOT LIMITED
* TO ANY IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A
* PARTICULAR PURPOSE."
* Models accurate up to 2 times rated drain current.
* Start of GB50SLT12-CAL SPICE Model
.SUBCKT GB50SLT12 ANODE KATHODE
R1 ANODE INT R=((TEMP-24)*9.39E-05); Temperature Dependant Resistor
D1 INT KATHODE GB50SLT12 25C; Call the 25C Diode Model
.MODEL GB50SLT12 25C D
+ IS
         1.99E-16
                          RS
                                    0.015652965
                         IKF
+ N
         1
                                    1000
+ EG
         1.2
                         XTI
                                    3
        3.86E-09
+ CJO
                        VJ
                                    1.362328465
+ M
         0.48198551
                         FC
                                    0.5
+ TT
                         BV
         1.00E-10
                                    1200
+ IBV 1.00E-03
                          VPK
                                    1200
+ IAVE
         50
                          TYPE
                                    SiC Schottky
      GeneSiC Semiconductor
+ MFG
.ENDS
* End of GB50SLT12-CAL SPICE Model
```